

IGBT Discrete with Anti-Parallel Diode

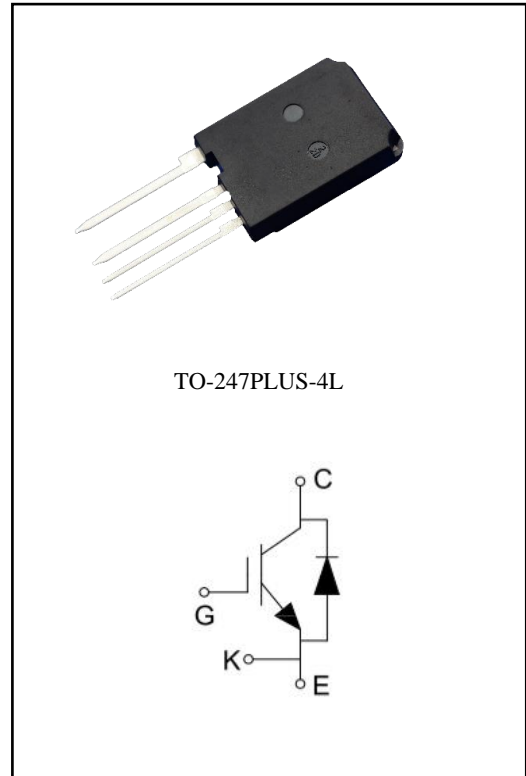
$V_{CES} = 1200V$, $I_{C\ nom} = 120A$ / $I_{CRM} = 360A$

Features :

- 1200V Trench /Field Stop type
- Low switching losses
- V_{cesat} has a positive temperature coefficient

Applications:

- Energy storage inverter
- Uninterruptible power supplies
- Solar inverters



IGBT

Maximum Ratings

Parameter	Conditions	Symbol	Value	Unit
Collector-Emitter voltage	$T_{vj} = 25^{\circ}C$	V_{CES}	1200	V
Continuous DC collector current	$T_C = 100^{\circ}C$, $T_{vj\ max} = 175^{\circ}C$	$I_{C\ nom}$	120	A
Repetitive peak collector current	$t_p = 1ms$	I_{CRM}	360	A
Gate emitter voltage		V_{GE}	± 20	V
Transient gate-emitter voltage	$t_p \leq 0.5\mu s$, $D < 0.001$	V_{GE}	± 25	V

Power dissipation	$T_C=25^\circ\text{C}$ $T_C=100^\circ\text{C}$	P_{tot}	1250 625	W
Temperature under switching conditions		$T_{\text{vj op}}$	-40...+175	$^\circ\text{C}$
Storage temperature		T_{stg}	-40...+150	$^\circ\text{C}$

Thermal Characteristics

Parameter	Conditions	Symbol	Value	Unit
IGBT thermal resistance, junction - case		$R_{\text{th(j-C)}}$	0.12	K/W
Diode thermal resistance, junction - case		$R_{\text{th(j-C)}}$	0.20	K/W

Characteristic Values

Parameter	Conditions	Symbol	Value			Unit	
			Min.	Typ.	Max.		
Collector-Emitter saturation voltage	$V_{\text{GE}}=15\text{V}, I_{\text{C}}=120\text{A}$ $V_{\text{GE}}=15\text{V}, I_{\text{C}}=120\text{A}$	$T_{\text{vj}}=25^\circ\text{C}$ $T_{\text{vj}}=175^\circ\text{C}$	V_{CEsat}	1.70 2.30	2.10	V	
Gate-Emitter threshold voltage	$I_{\text{C}}=2.34\text{mA}, V_{\text{GE}}=V_{\text{CE}}$	$T_{\text{vj}}=25^\circ\text{C}$	$V_{\text{GE(th)}}$	5.2	5.8	6.4	V
Transconductance	$V_{\text{CE}}=20\text{V}, I_{\text{C}}=120\text{A}$		G_{fs}	96		S	
Input capacitance	$f=100\text{kHz}, V_{\text{CE}}=25\text{V}, V_{\text{GE}}=0\text{V}$	$T_{\text{vj}}=25^\circ\text{C}$	C_{ies}	16.81		nF	
Output capacitance			C_{oes}	0.41		nF	
Reverse transfer capacitance			C_{res}	0.13		nF	
Gate charge	$I_{\text{C}}=120\text{A}, V_{\text{GE}}=15\text{V}, V_{\text{CE}}=960\text{V}$	$T_{\text{vj}}=25^\circ\text{C}$	Q_{G}	1.03		μC	
Collector-emitter cut-off current	$V_{\text{CE}}=1200\text{V}, V_{\text{GE}}=0\text{V}$	$T_{\text{vj}}=25^\circ\text{C}$	I_{CES}		40	μA	
Gate-emitter leakage current	$V_{\text{CE}}=0\text{V}, V_{\text{GE}}=20\text{V}$	$T_{\text{vj}}=25^\circ\text{C}$	I_{GES}		100	nA	
Turn-on delay time	$I_{\text{C}}=120\text{A}, V_{\text{CE}}=600\text{V}$ $V_{\text{GE}}=\pm 15\text{V}, R_{\text{G}}=20\Omega$ (inductive load)	$T_{\text{vj}}=25^\circ\text{C}$ $T_{\text{vj}}=175^\circ\text{C}$	$t_{\text{d(on)}}$	235 175		ns	
Rise time	$I_{\text{C}}=120\text{A}, V_{\text{CE}}=600\text{V}$ $V_{\text{GE}}=\pm 15\text{V}, R_{\text{G}}=20\Omega$ (inductive load)	$T_{\text{vj}}=25^\circ\text{C}$ $T_{\text{vj}}=175^\circ\text{C}$	t_{r}	137 139		ns	

Turn-off delay time	$I_C=120A, V_{CE}=600V$ $V_{GE}=\pm 15V, R_G=20\Omega$ (inductive load)	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	$t_{d(off)}$	435 489		ns
Fall time	$I_C=120A, V_{CE}=600V$ $V_{GE}=\pm 15V, R_G=20\Omega$ (inductive load)	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	t_f	69 126		ns
Turn-on energy loss per pulse	$I_C=120A, V_{CE}=600V$ $V_{GE}=\pm 15V, R_G=20\Omega$ $di/dt=700A/\mu s(T_{vj}=175^\circ C)$ (inductive load)	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	E_{on}	14.60 19.74		mJ
Turn-off energy loss per pulse	$I_C=120A, V_{CE}=600V$ $V_{GE}=\pm 15V, R_G=20\Omega$ $dv/dt=7500V/\mu s(T_{vj}=175^\circ C)$ (inductive load)	$T_{vj}=25^\circ C$ $T_{vj}=175^\circ C$	E_{off}	4.41 6.74		mJ

Diode

Maximum Ratings

Parameter	Conditions	Symbol	Value	Unit
Repetitive peak reverse voltage	$T_{vj}=25^\circ C$	V_{RRM}	1200	V
Continuous DC forward current	$T_C=100^\circ C, T_{vj\ max}=175^\circ C$	I_F	120	A
Repetitive peak forward current	$t_p=1ms$	I_{FRM}	360	A

Characteristic Values

Parameter	Conditions	Symbol	Value			Unit
			Min.	Typ.	Max.	
Forward voltage	$I_F=120A, V_{GE}=0V$ $I_F=120A, V_{GE}=0V$	V_F		1.75 1.96	2.2	V
Peak reverse recovery current	$I_F=120A,$ $-di_F/dt=700A/\mu s(T_{vj}=175^\circ C)$ $V_R=600V, V_{GE}=-15V$	I_{RM}		42 66		A
Reverse Recovered charge	$I_F=120A,$ $-di_F/dt=700A/\mu s(T_{vj}=175^\circ C)$ $V_R=600V, V_{GE}=-15V$	Q_{rr}		8.19 20.97		μC
Reverse Recovery Time	$I_F=120A,$ $-di_F/dt=700A/\mu s(T_{vj}=175^\circ C)$ $V_R=600V, V_{GE}=-15V$	t_{rr}		428 668		ns
Reverse recovered energy	$I_F=120A,$ $-di_F/dt=700A/\mu s(T_{vj}=175^\circ C)$ $V_R=600V, V_{GE}=-15V$	E_{rec}		2.84 8.11		mJ

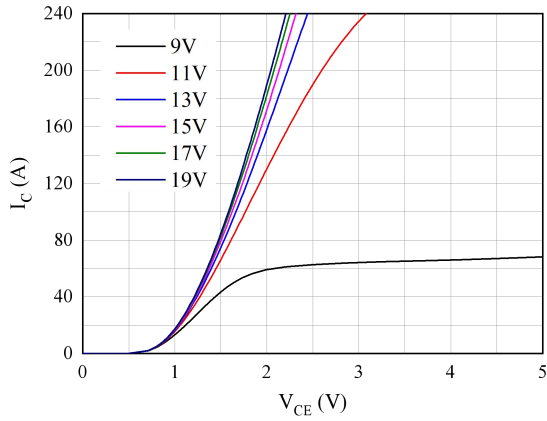


Fig 1. Typical output characteristics ($T_{vj}=25^{\circ}\text{C}$)

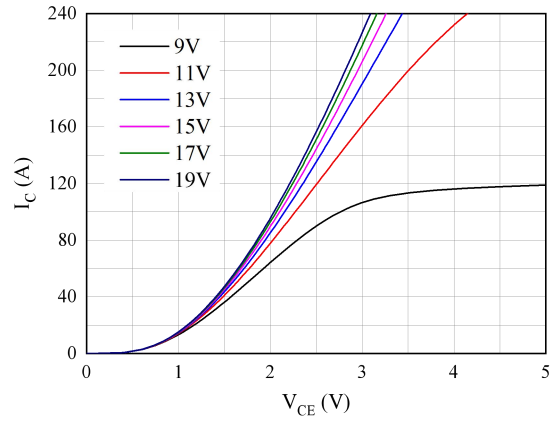


Fig 2. Typical output characteristics ($T_{vj}=175^{\circ}\text{C}$)

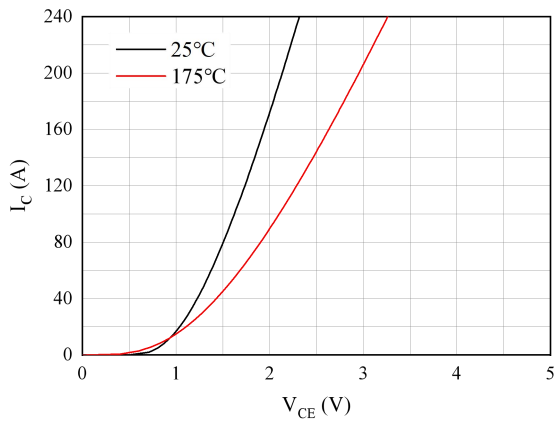


Fig 3. Typical output characteristics ($V_{ge}=15\text{V}$)

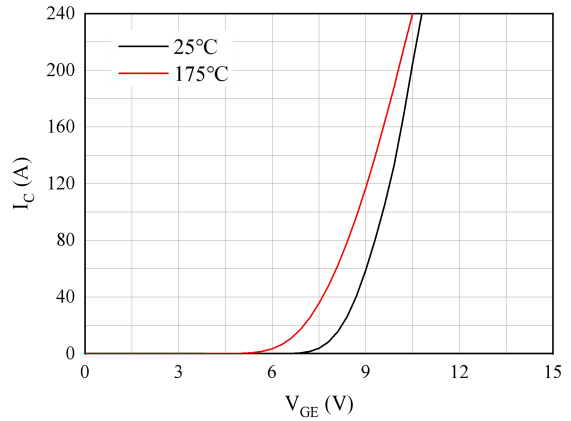


Fig 4. Typical transfer characteristic ($V_{ce}=20\text{V}$)

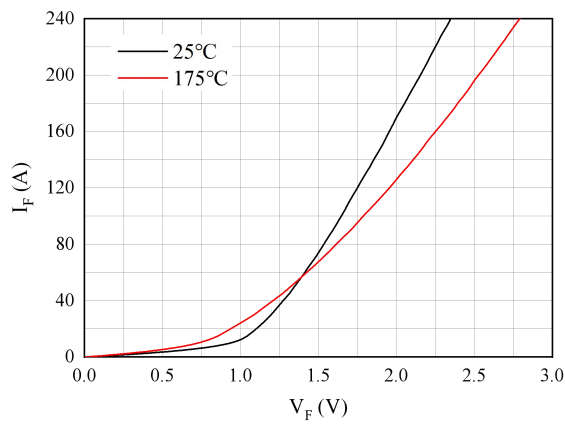


Fig 5. Forward characteristic of Diode

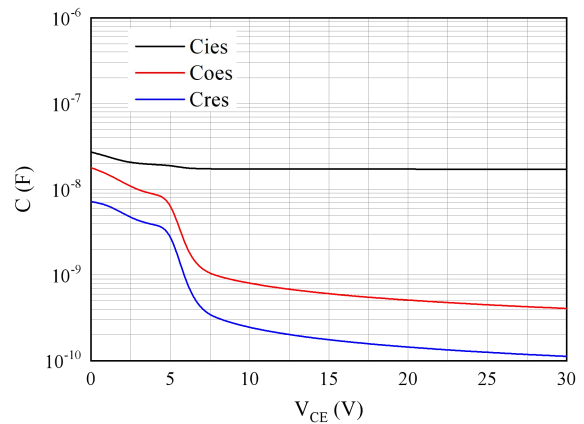


Fig 6. Capacitance characteristic

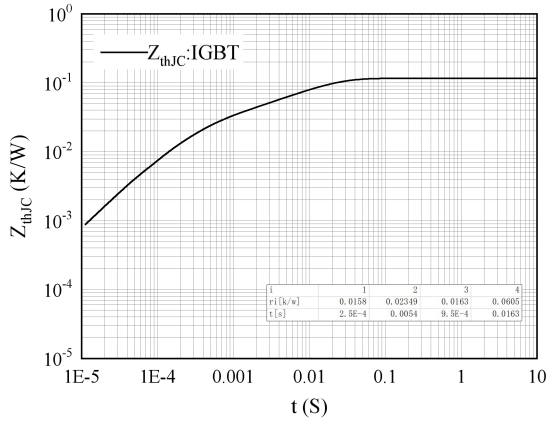


Fig 7. Transient thermal impedance IGBT,
 $Z_{thJC}=f(t)$

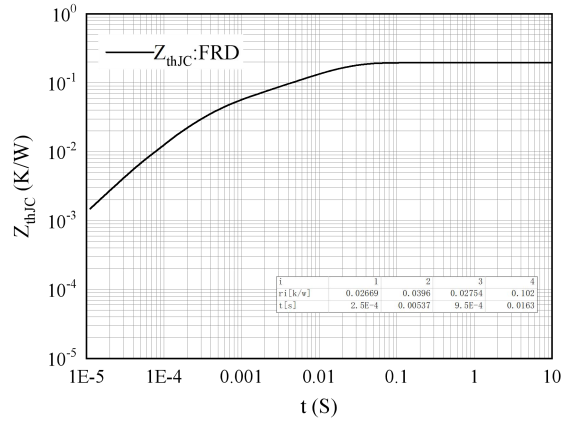


Fig 8. Transient thermal impedance FRD,
 $Z_{thJC}=f(t)$

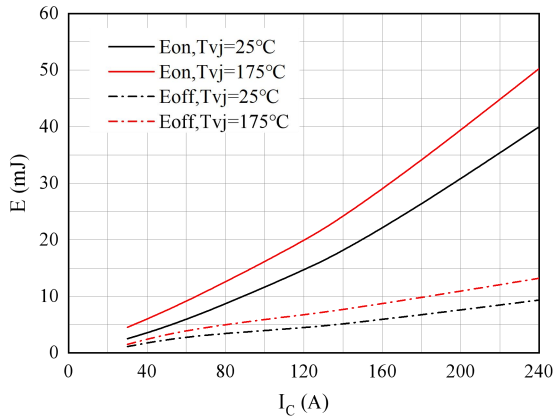


Fig 9. Switching losses of IGBT
 $V_{GE}=\pm 15V, R_{gon}=20\Omega, R_{goff}=20\Omega, V_{CE}=600V$

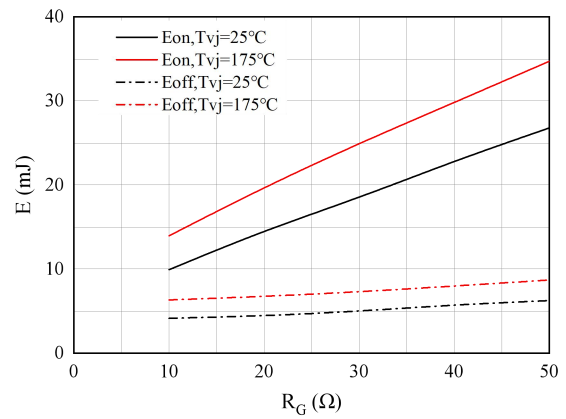


Fig 10. Switching losses of IGBT
 $V_{GE}=\pm 15V, I_C=120A, V_{CE}=600V$

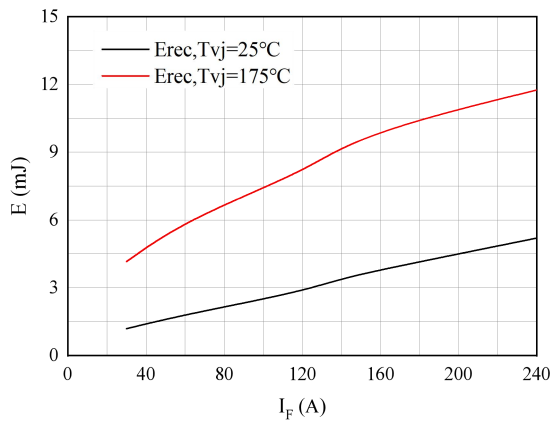


Fig 11. Switching losses of Diode
 $R_{gon}=20\Omega, V_{CE}=600V$

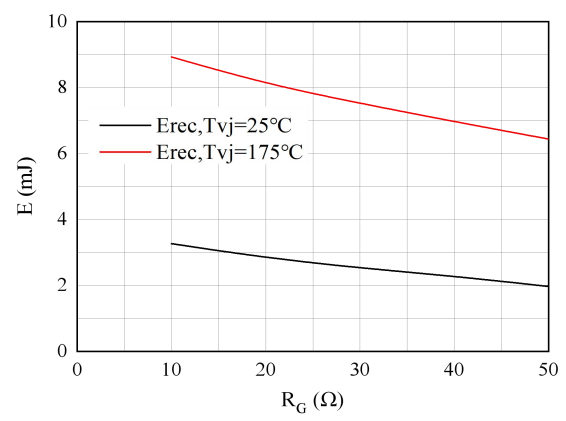
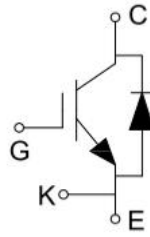
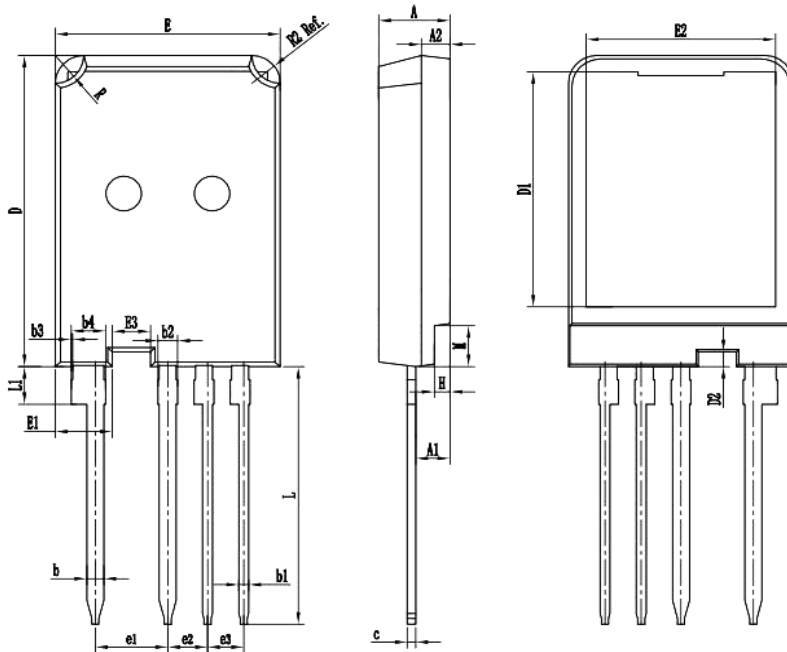


Fig 12. Switching losses of Diode
 $I_F=120A, V_{CE}=600V$

Circuit diagram



Package outlines



Symbol	Dimensions in Millimeters	
	Min	Max
A	4.900	5.100
A1	2.310	2.510
A2	1.900	2.100
b	1.160	1.290
b1	0.650	0.790
b2	1.360	1.490
b3	0.000	0.200
b4	2.160	2.290
c	0.590	0.660
D	22.300	22.500
D1	16.650	17.250
D2	1.000	1.100
E	15.700	15.900
E1	3.900	4.100
E2	13.100	13.500
E3	2.580	2.780
e1	5.080 BSC	
e2	2.790 BSC	
e3	2.540 BSC	
H	1.000	1.200
L	18.460	18.660
L1	2.620	2.820
M	2.850	3.050
R	1.900	2.100